

Search Notes

Application/Control No.

10/575,446

Examiner

/Yonel Beaulieu/

Applicant(s)/Patent under
Reexamination

TAKAMATSU ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	51-61	9/29/2008	YB
477	34		
474	69-70		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	9/29/2008	YB